Application/Control No. Applicant(s)/Patent Under Reexamination 10/773,930 LI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Sin J. Lee 1752 **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-2005/0058930 A1 03-2005 Α Li et al. 430/270.1 US-В US-С US-D US-Ε US-F US-G US-Н US-USĸ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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